Dynamic Differential Hall Effect Sensor IC

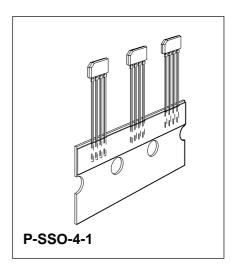
TLE 4921-2

Bipolar IC

Preliminary Data

Features

- AC coupled
- Digital output signal
- Two-wire and three-wire configuration possible
- Large temperature range
- Large distance, low frequency cut-off
- Protection against overvoltage
- Protection against reversed polarity
- Output protection against electrical disturbances

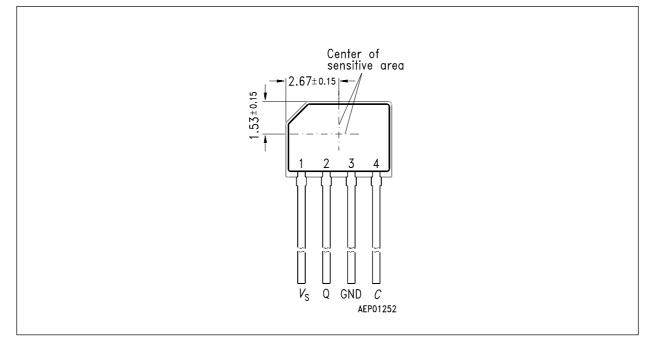


	Туре	Ordering Code	Package
▼	TLE 4921-2U	Q67006-A9055	P-SSO-4-1

New type

The differential Hall Effect sensor TLE 4921-2U is particularly suitable for rotational speed detection and timing applications of ferromagnetic toothed wheels such as anti-lock braking systems, transmissions, crankshafts, etc. The integrated circuit (based on Hall effect) provides a digital signal output with frequency proportional to the speed of rotation. Unlike other rotational sensors differential Hall ICs are not influenced by radial vibration within the effective airgap of the sensor and require no external signal processing.

Pin Configuration (top view)



Pin Definitions and Functions

Pin No.	Symbol	Function
1	Vs	Supply voltage
2	Q	Output
3	GND	Ground
4	С	Capacitor

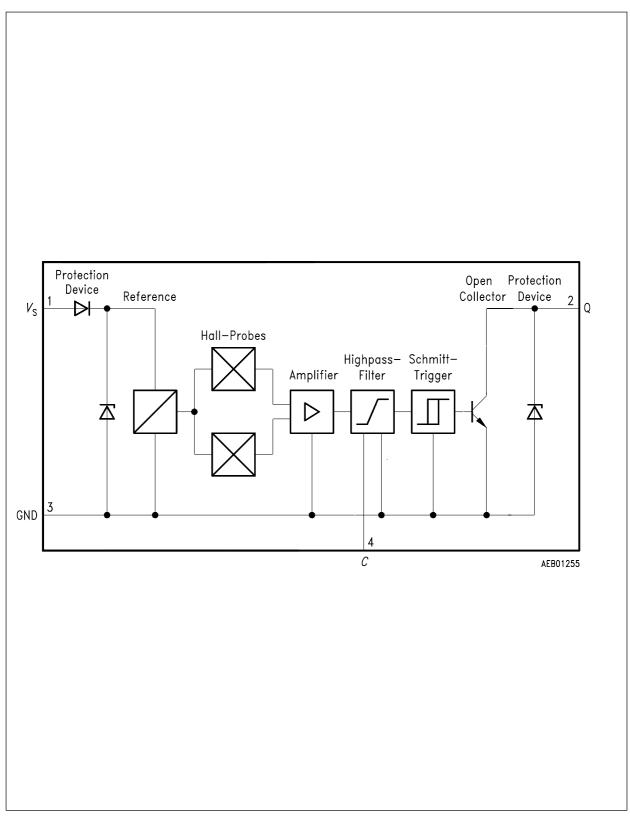


Figure 1 Block Diagram 1

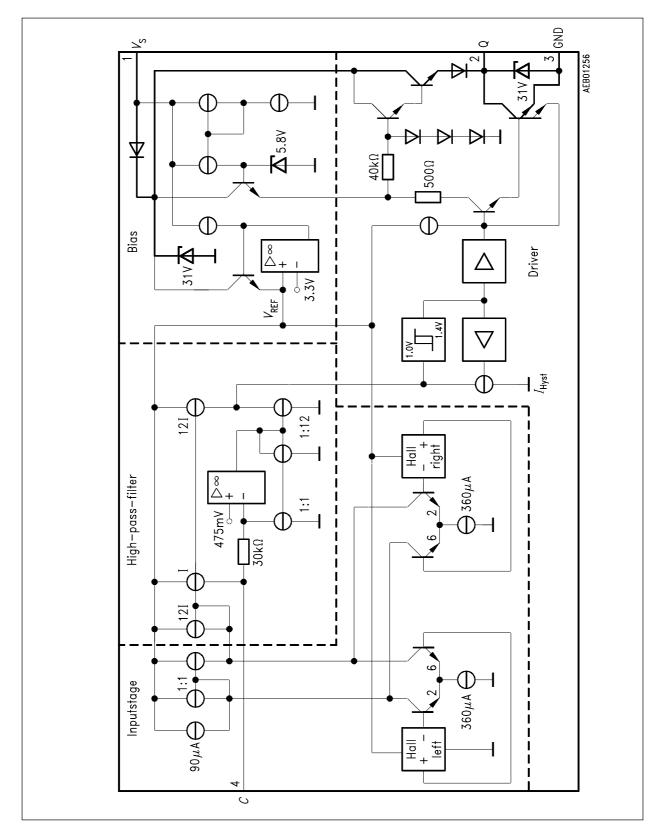


Figure 2 Block Diagram 2

Functional Description

The Differential Hall Sensor IC detects the motion of, and static position of, ferromagnetic and permanent magnet structures by measuring the differential flux density of the magnetic field. To detect ferromagnetic objects the magnetic field must be provided by a back biasing permanent magnet (southpole of the magnet attached to the back, unmarked, side of the IC package).

Using an external capacitor the generated Hall-voltage signal is slowly adjusted via an active high pass filter with low frequency cutoff. This causes the output to switch into a biased mode after a time constant is elapsed. The time constant is determined by the external capacitor. Filtering avoids aging and temperature influence from Schmitt-trigger input and eliminates device and magnetic offset.

The TLE 4921-2U can be exploited to detect toothed wheel rotation in a rough environment. Jolts against the toothed wheel and ripple have no influence on the output signal. Furthermore the TLE 4921-2U can be operated in a two-wire - as well as in a three-wire-configuration.

The output is logic compatible by high/low levels regarding on and off.

Circuit Description (see Figure 1 and 2)

The TLE 4921-2U is comprised of a supply voltage reference, a pair of Hall probes spaced at 2.5 mm, differential amplifier, Schmitt trigger, and open collector output.

Protection is provided at the input/supply (pin 1) for overvoltage and reverse polarity and against overstress such as load dump, etc., in accordance with ISO-TR 7637 and DIN 40839. The output (pin 2) is protected against voltage peaks and electrical disturbances.

Absolute Maximum Ratings

 $T_{\rm i} = -40$ to 150 °C

Parameter	Symbol	Limit Values		Units	Remarks	
		min.	max.			
Supply voltage	Vs	- 40	30	V		
Output voltage	V _Q	- 0.7	30	V		
Output current	IQ		50	mA		
Output revers current	$-I_Q$		50	mA		
Capacitor voltage	V _c	- 0.3	3	V		
Junction temperature	Tj		150	°C		
Junction temperature	T_{j}		170	°C	1000 h	
Junction temperature	T_{j}		210	°C	40 h	
Storage temperature	T _s	- 40	150	°C		
Thermal resistance						
PSSO-4-1	$R_{ m th~JA}$		190	K/W		
Current through input-	I _{SZ}		200	mA	<i>t</i> < 2 ms ; <i>v</i> = 0.1	
protection device						
Current through output-	I _{QZ}	- 200	200	mA	t < 2 ms; $v = 0.1$	
protection device						

Electro Magnetic Compatibility

ref. DIN 40839 part 1; test circuit 1

Testpulse 1	V_{LD}	- 100		V	$t_{\rm d} = 2 {\rm ms}$
Testpulse 2	V_{LD}		100	V	$t_{\rm d} = 0.05 \ {\rm ms}$
Testpulse 3a	V_{LD}	- 150		V	$t_{\rm d} = 0.1 \ \mu { m s}$
Testpulse 3b	V_{LD}		100	V	$t_{\rm d} = 0.1 \ \mu { m s}$
Testpulse 4	V_{LD}	-7		V	<i>t</i> _d ≤ 20 s
Testpulse 5	V_{LD}		120	V	$t_{\rm d} = 400 {\rm ms};$
					$R_{\rm p} = 450 \ \Omega$

Operating Range

Supply voltage	Vs	4.5	24	V	
Junction temperature	T _i	- 40	150	°C	
Junction temperature	T_{j}	- 40	170	°C	thresholds may exceed the limits
Pre-induction	B ₀	0	200	mT	Southpole at the
					backside of IC

AC/DC Characteristics

Parameter	Symbol	Limit Values			Unit	Test Condition	Test
		min.	typ.	max.			Circuit
Supply voltage	Vs					$4.5 V \le V_{\rm S}$ $\le 24 V$	
Junction temperature	T _j					- 40 °C ≤ T _j ≤ 150 °C	
Supply current	Is	3.5 4.0	8.5 9	14 14.5	mA mA	$V_{\rm Q}$ = high $I_{\rm Q}$ = 0 mA $V_{\rm Q}$ = low $I_{\rm Q}$ = 40 mA	1
Output saturation voltage	V_{QSat}		0.25	0.6	V	$I_{\rm Q} = 40 \text{ mA}$	1
Output leakage current	I _{QL}			10	μA	$V_{\rm Q}$ = 24 V	1
Switching frequency	f	5		20000	Hz	C = 470 nF $\Delta B = 5 \text{ mT}$	2
Switching flux density	ΔB_{OP}	-2	0	1	mT	f = 100 Hz; $B_0 = 150 \text{ mT}$ C = 470 nF; $\Delta B_{max} = 1.75 \text{ mT}$	2
Hysteresis	$\Delta B_{ m Hy}$	0.5	1.5	2.5	mT	f = 100 Hz; $B_0 = 150 \text{ mT}$ C = 470 nF; $\Delta B_{max} = 1.75 \text{ mT}$	2
Overvoltage protection at supply voltage at output	$V_{ m SZ}$ $V_{ m QZ}$	27 27		35 35	V V	$I_{\rm S}$ = 16 mA $I_{\rm S}$ = 16 mA	2 2

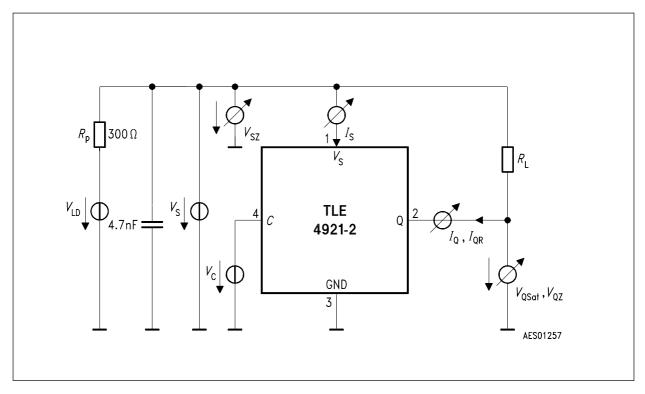


Figure 3 Test Circuit 1

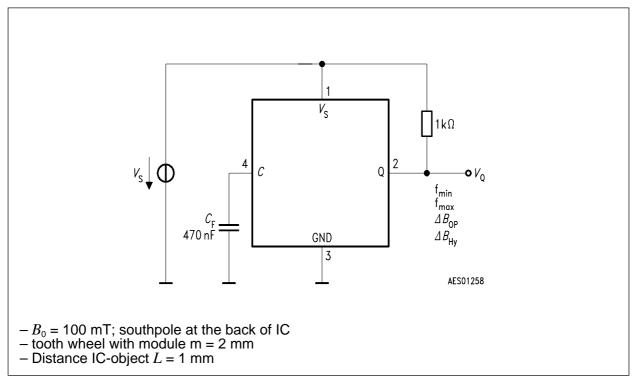


Figure 4 Test Circuit 2

Application Notes

Two possible applications are shown in figure 7 and 8 (Toothed and Magnet Wheel).

The differences between two-wire and three-wire application is shown in figure 9.

Gear Tooth Sensing

In the case of ferromagnetic toothed wheel application the IC has to be biased by the southpole of a permanent magnet (e.g. SEC_{o5} (Vacuumschmelze VX145) with the dimensions 8 mm x 5 mm x 3 mm) which should cover both hall-probes.

The maximum air gap depends on

- the magnetic field strength (magnet used),
- the tooth wheel that is used (dimensions, material, etc.),
- the ambient temperature,
- the connected capacitor

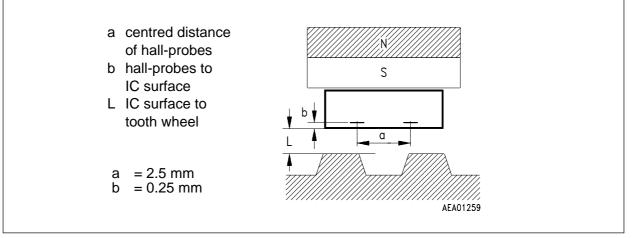
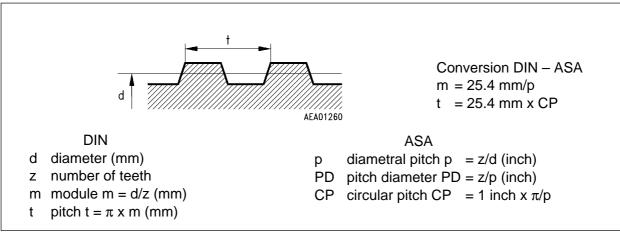
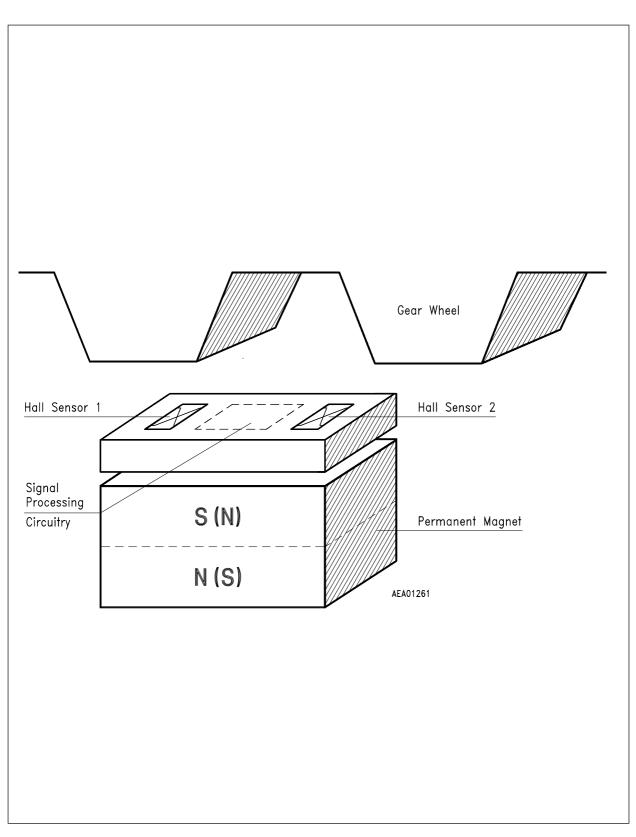


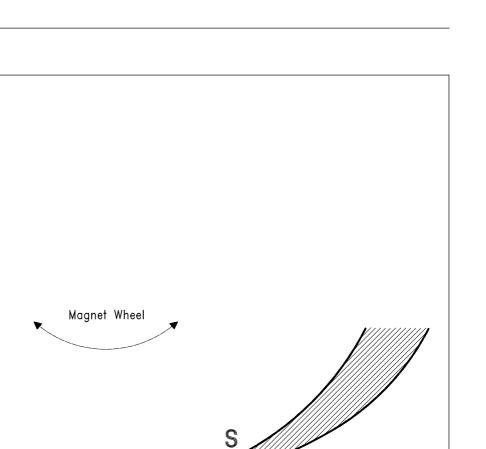
Figure 5 Sensor Spacing

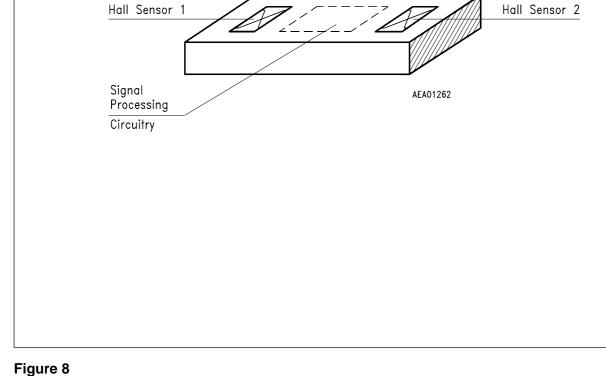






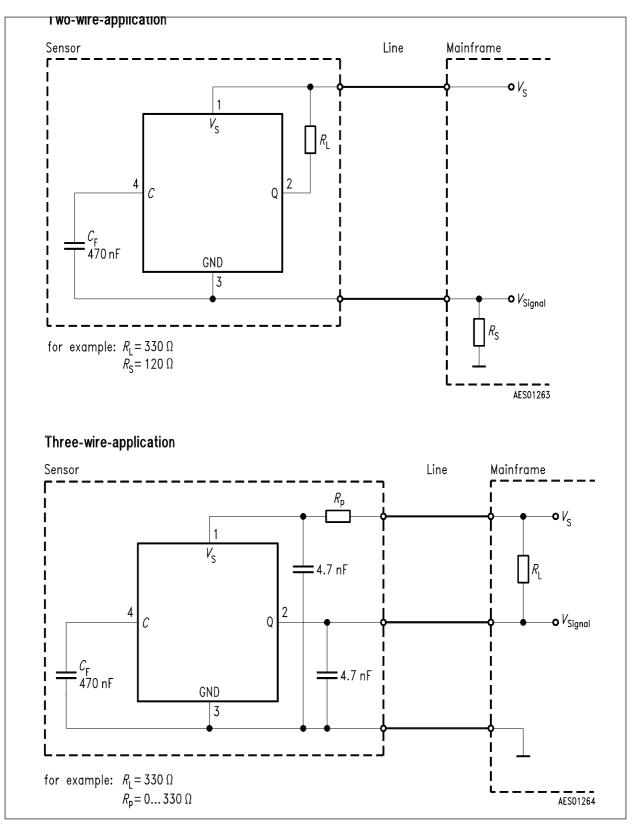
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Figure 8 TLE 4921-2U, with Magnet Wheel





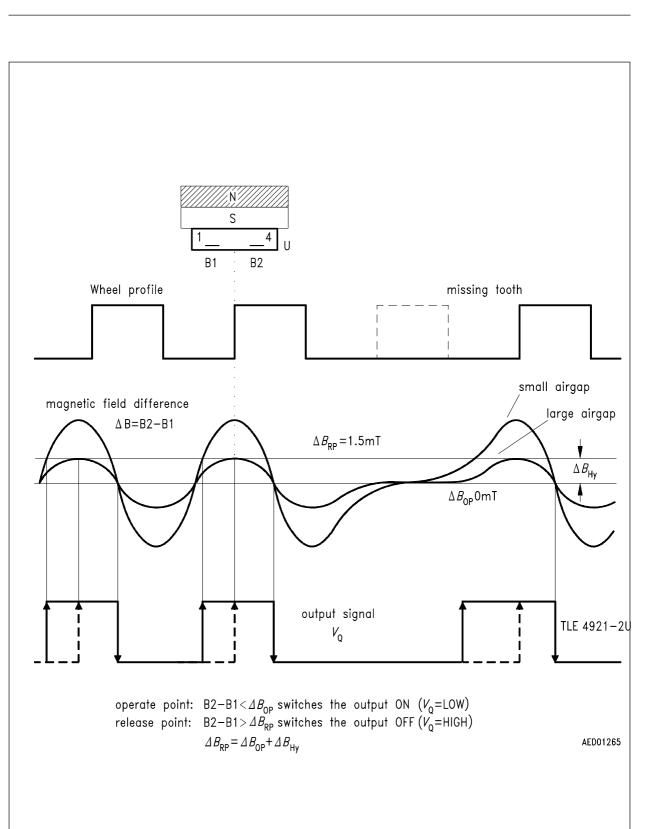
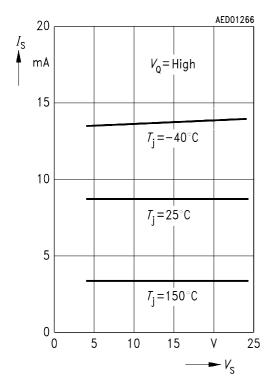
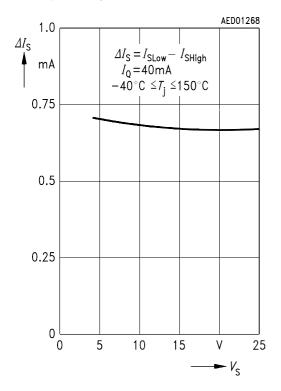


Figure 10 System Operation

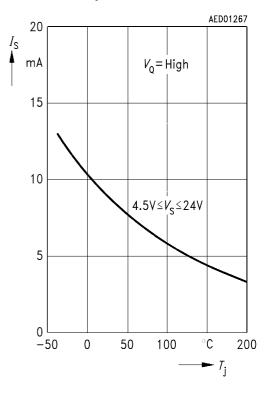
Quiescent Current versus Supply Voltage



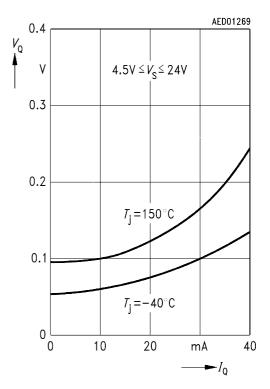
Quiescent Current Difference versus Supply Voltage



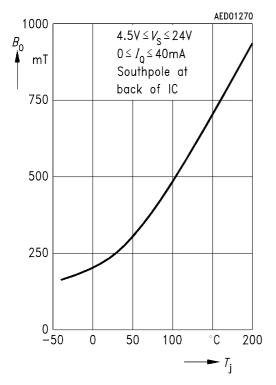




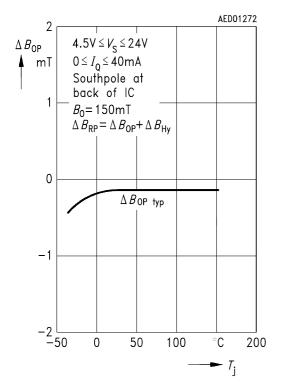
Saturation Voltage versus Output Current



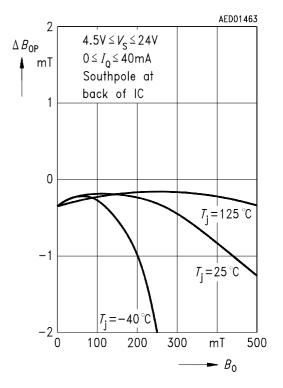
Maximum Preinduction versus Junction Temperature



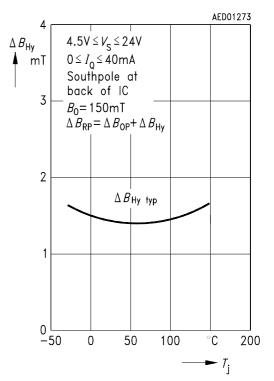
Switching Induction versus Temperature



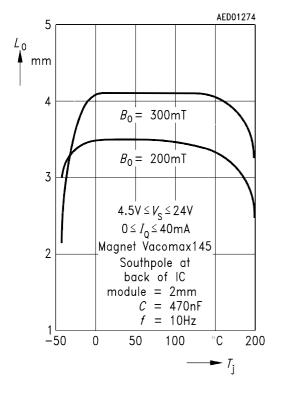
Switching Induction versus Preinduction



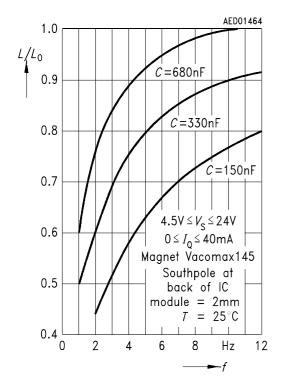
Hysteresis Induction Versus Junction Temperature



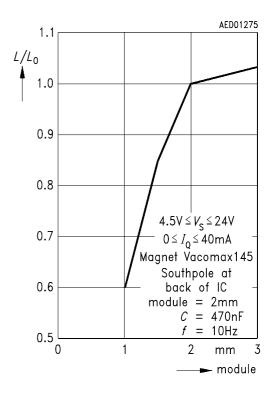
Distance IC-tooth Wheel versus Junction Temperature



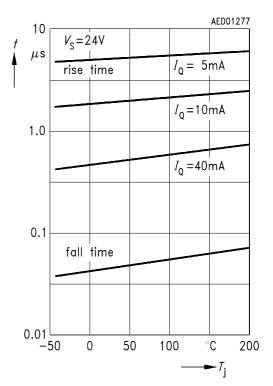
Relative Distance versus Switching Frequency



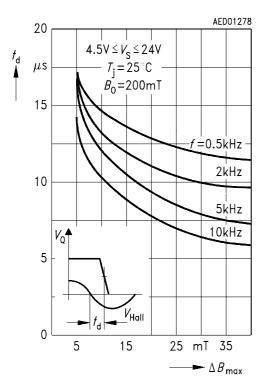
Relative Distance versus Module



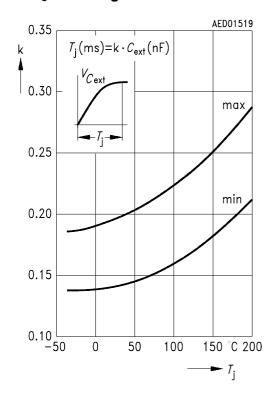
Fall- and Rise-Time versus Junction Temperature



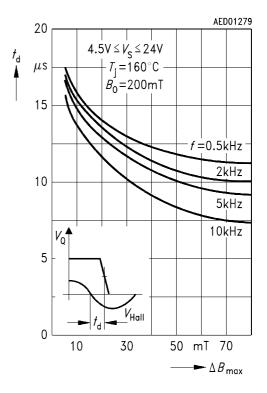
Delay Time between Zero-Axis Crossing of ΔB and Falling Edge of V_{q} at T_{j} = 25 °C



Delay time $T_{\rm j}$ versus Junction Temperature for $V_{\rm S}$ Switching from 0 V to 4.5 V



Delay Time between Zero-Axis Crossing of ΔB and Falling Edge of V_{q} at T_{i} = 160 °C



Influence of Filter and Delay Time for Different ΔB_{max} values

